




<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10040643	CZEIGER ET AL.
	Examiner Nguyen, Tammy T	Art Unit 2144

Notes	Date	Examiner
UPDATED SEARCH EAST	8/2/06	TTN
CONSULT VAUGHN WILLIAM	7/30/06	TTN
PLUS SEARCH	8/1/06	TTN
US-PGPUB, USPAT, EPO, JPO, DERWENT	8/2/06	TTN
ACM	7/31/06	TTN
IEEE	7/31/06	TTN
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<b>Interference Searched</b>  	Application/Control No.  10040643	Applicant(s)/Patent Under Reexamination  CZEIGER ET AL.
	Examiner Nguyen, Tammy T	Art Unit 2144

Class	SubClass	Date	Examiner
709	218	08/02/2006	TTN
709	221	08/02/2000	TTN
709	201	08/02/2006	TTN
709	217	8/2/06	TTN

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<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10040643</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>CZEIGER ET AL.</p>
	<p>Examiner</p> <p>Nguyen, Tammy T</p>	<p>Art Unit</p> <p>2144</p>

Class	SubClass	Date	Examiner
709	218	08/02/2006	TTN
709	201	08/02/2008	TTN
711	114	08/02/2006	TTN
370	217	08/02/2006	TTN
370	389	08/02/2006	TTN
709	221		
709	217	8/2/06	TTN

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